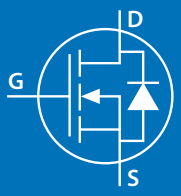
EPC2067 – Enhancement Mode Power Transistor

V_{DS}, 40 V

Max $R_{DS(on)}$, 1.55 mΩ

I_D, 69 A



EFFICIENT POWER CONVERSION

RoHS Halogen-Free

Revised October 21, 2021

Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR}. The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

Questions: Ask a GaN Expert

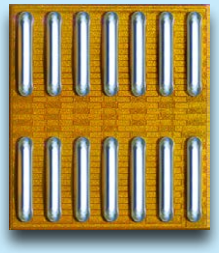
Maximum Ratings			
PARAMETER		**VALUE**	**UNIT**
V_{DS}	Drain-to-Source Voltage (Continuous)	40	V
	Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)	48	
I_D	Continuous (T_A = 25°C)	69	A
	Pulsed (25°C, T_{PULSE} = 300 µs)	409	
V_{GS}	Gate-to-Source Voltage	6	V
	Gate-to-Source Voltage	-4	
T_J	Operating Temperature	–40 to 150	°C
T_{STG}	Storage Temperature	–40 to 150	

Thermal Characteristics			
PARAMETER		**TYP**	**UNIT**
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.4	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Board	1.4	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1)	48	

Note 1: $R_{\theta JA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. See https://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details.

Static Characteristics (T_J = 25°C unless otherwise stated)						
PARAMETER		**TEST CONDITIONS**	**MIN**	**TYP**	**MAX**	**UNIT**
BV_{DSS}	Drain-to-Source Voltage	V_{GS} = 0 V, I_D = 1.1 mA	40			V
I_{DSS}	Drain-Source Leakage	V_{GS} = 0 V, V_{DS} = 32 V		0.01	0.9	mA
I_{GSS}	Gate-to-Source Forward Leakage	V_{GS} = 5 V		0.002	4	
	Gate-to-Source Forward Leakage#	V_{GS} = 5 V, T_J = 125°C		0.2	9	
	Gate-to-Source Reverse Leakage	V_{GS} = -4 V		0.01	1	
$V_{GS(TH)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 18 mA	0.7	1	2.5	V
$R_{DS(on)}$	Drain-Source On Resistance	V_{GS} = 5 V, I_D = 37 A		1.3	1.55	mΩ
V_{SD}	Source-Drain Forward Voltage#	I_S = 0.5 A, V_{GS} = 0 V		1.2		V

Defined by design. Not subject to production test.



Die Size: 2.85 x 3.25 mm

EPC2067 eGaN® FETs are supplied only in passivated die form with solder bars.

Applications

- High frequency DC-DC converters
- BLDC motor drives
- Sync rectification for AC-DC and DC-DC

Benefits

- High power density
- High efficiency
- No reverse recovery
- Ultra Low Q_G
- Small footprint
- High frequency capability

Scan QR code or click link below for more information including reliability reports, device models, demo boards!

https://l.ead.me/EPC2067

Dynamic Characteristics# (T_J = 25°C unless otherwise stated)						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
C_{ISS}	Input Capacitance	V_{DS} = 20 V, V_{GS} = 0 V		2178	3267	pF
C_{RSS}	Reverse Transfer Capacitance			24		
C_{OSS}	Output Capacitance			1071	1607	
$C_{OSS(ER)}$	Effective Output Capacitance, Energy Related (Note 2)	V_{DS} = 0 to 20 V, V_{GS} = 0 V		1597		
$C_{OSS(TR)}$	Effective Output Capacitance, Time Related (Note 3)			1860		
R_G	Gate Resistance			0.4		Ω
Q_G	Total Gate Charge	V_{DS} = 20 V, V_{GS} = 5 V, I_D = 37 A		17.1	22.3	nC
Q_{GS}	Gate-to-Source Charge	V_{DS} = 20 V, I_D = 37 A		5.3		
Q_{GD}	Gate-to-Drain Charge			2		
$Q_{G(TH)}$	Gate Charge at Threshold			4.2		
Q_{OSS}	Output Charge	V_{DS} = 20 V, V_{GS} = 0 V		37	56	
Q_{RR}	Source-Drain Recovery Charge			0		

Defined by design. Not subject to production test.
All measurements were done with substrate connected to source.
Note 2: $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.
Note 3: $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Figure 1: Typical Output Characteristics at 25°C

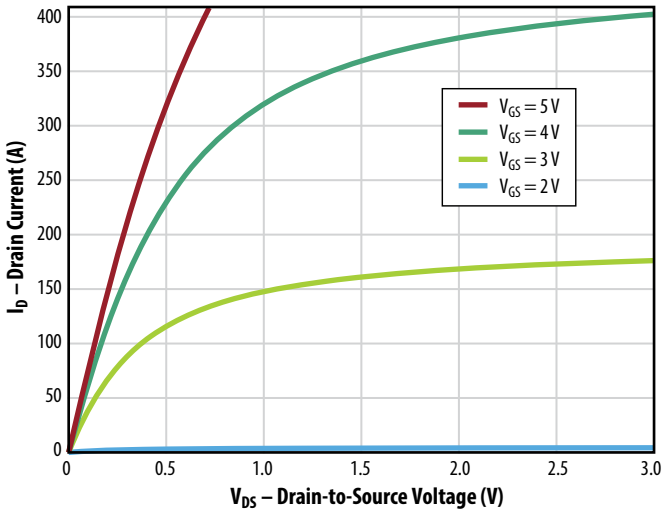


Figure 2: Typical Transfer Characteristics

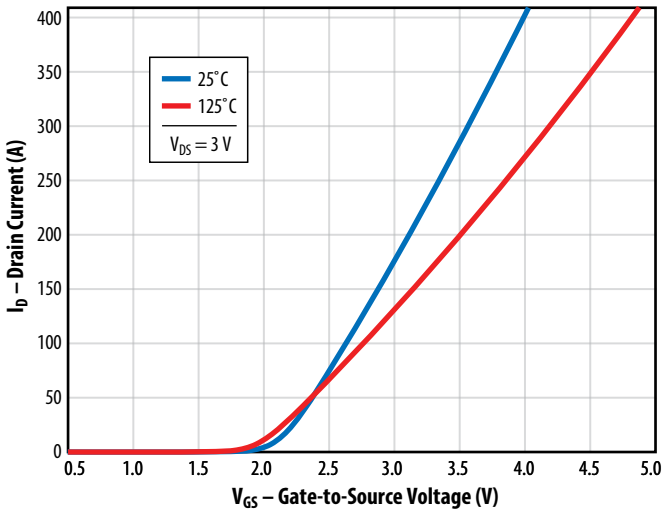


Figure 3: Typical $R_{DS(on)}$ vs. V_{GS} for Various Drain Currents

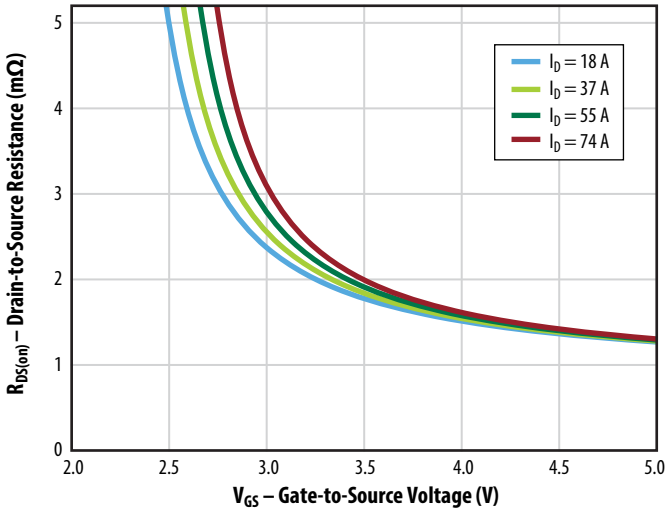


Figure 4: Typical $R_{DS(on)}$ vs. V_{GS} for Various Temperatures

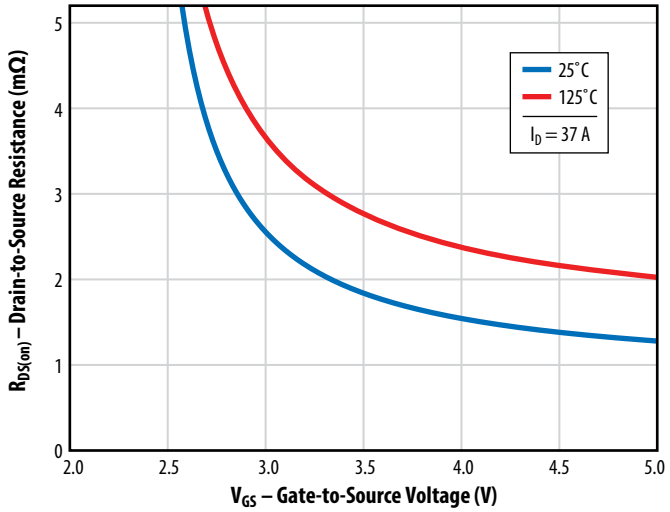


Figure 5a: Typical Capacitance (Linear Scale)

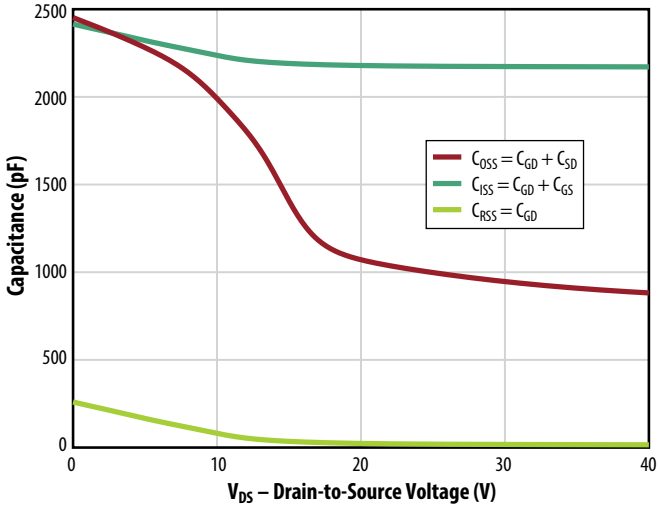


Figure 5b: Typical Capacitance (Log Scale)

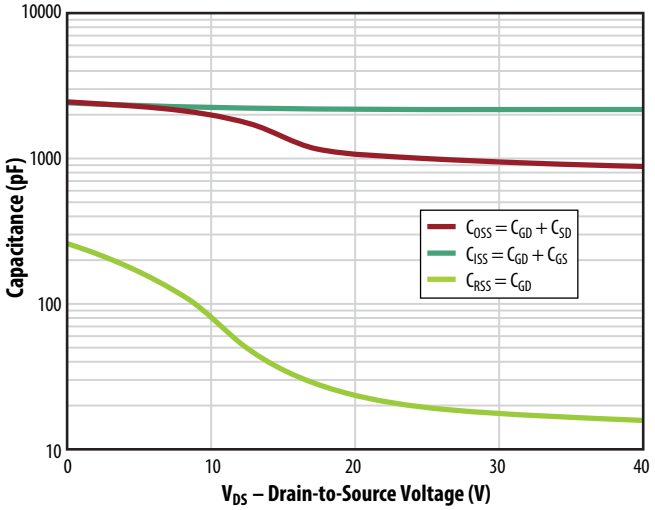


Figure 6: Typical Output Charge and C_{OSS} Stored Energy

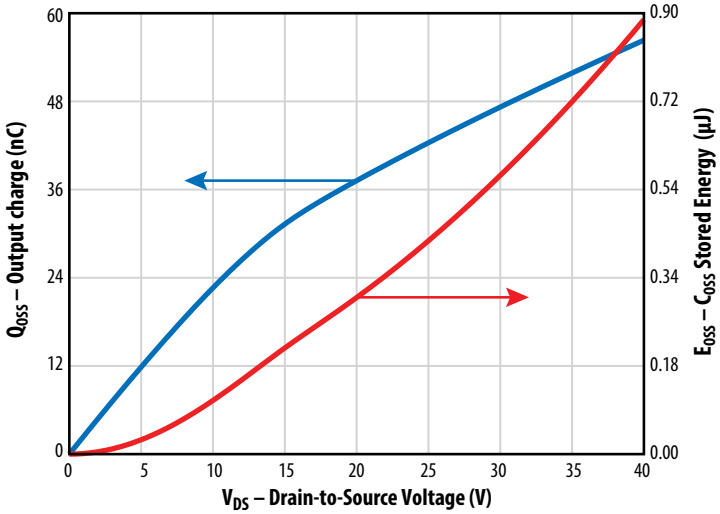


Figure 7: Typical Gate Charge

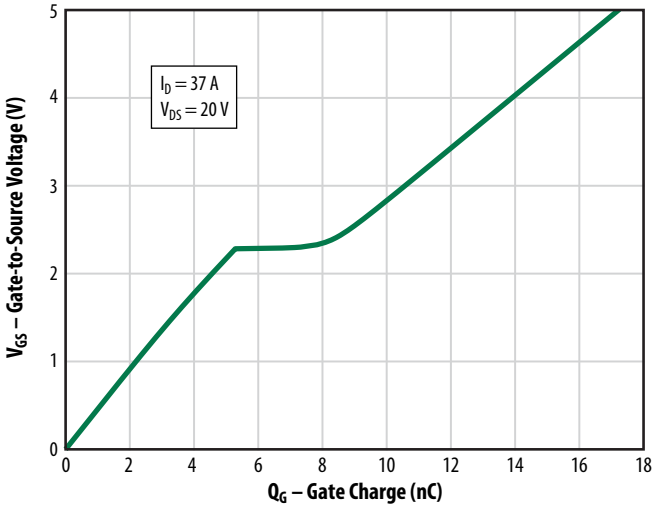


Figure 8: Typical Reverse Drain-Source Characteristics

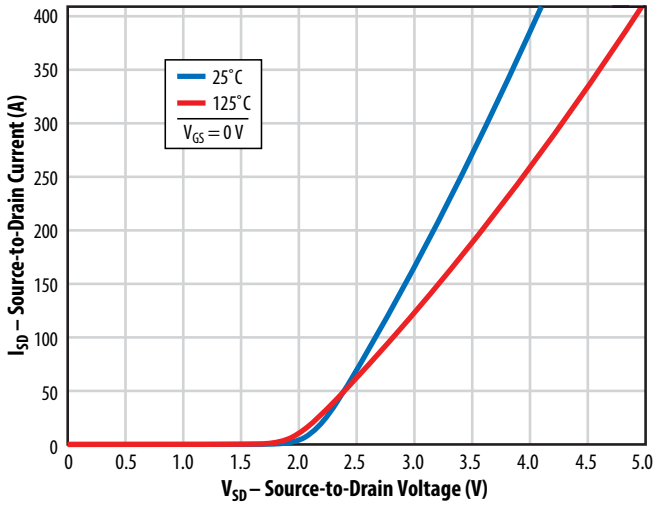
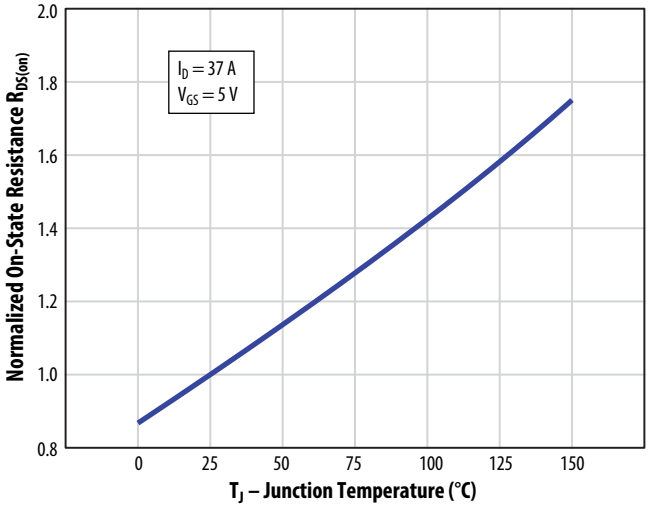


Figure 9: Typical Normalized On-State Resistance vs. Temp.



Note: Negative gate drive voltage increases the reverse drain-source voltage. EPC recommends 0 V for OFF.

Figure 10: Typical Normalized Threshold Voltage vs. Temperature

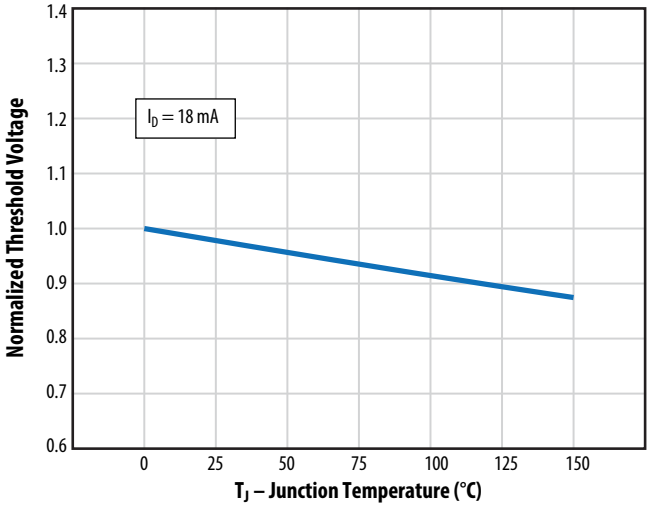


Figure 11: Typical Transient Thermal Response Curves

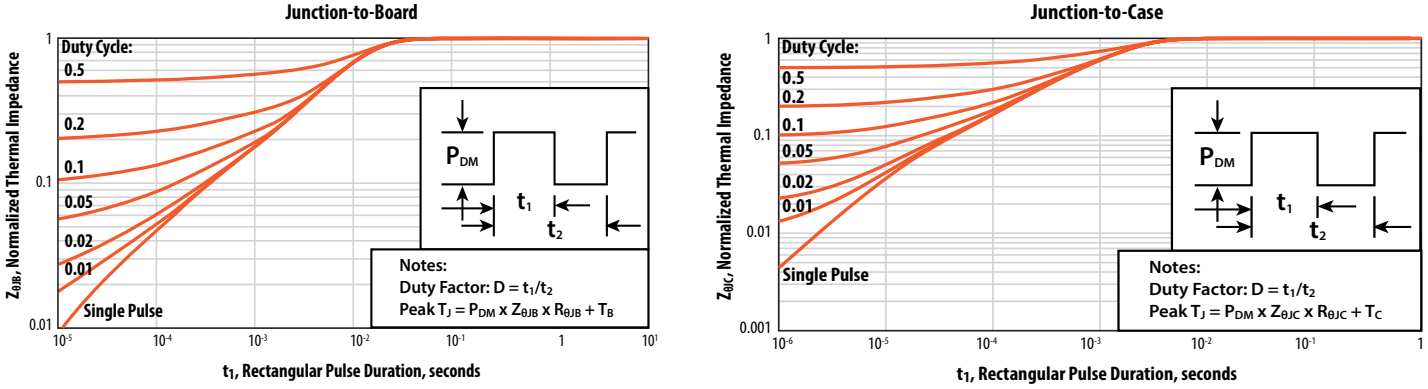
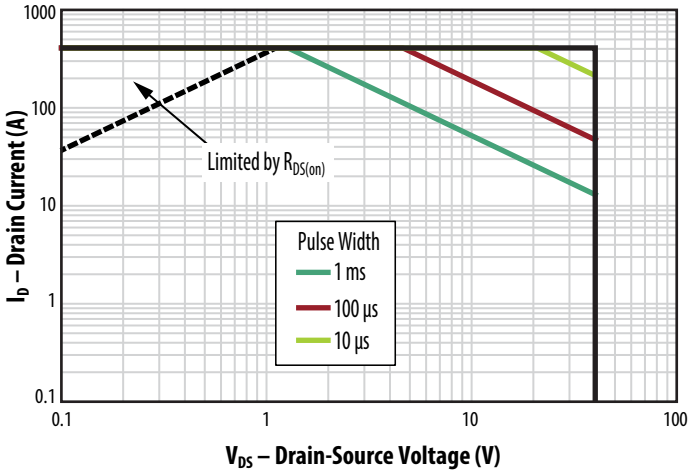
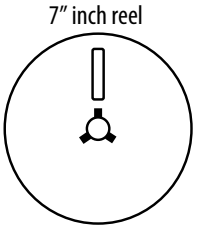


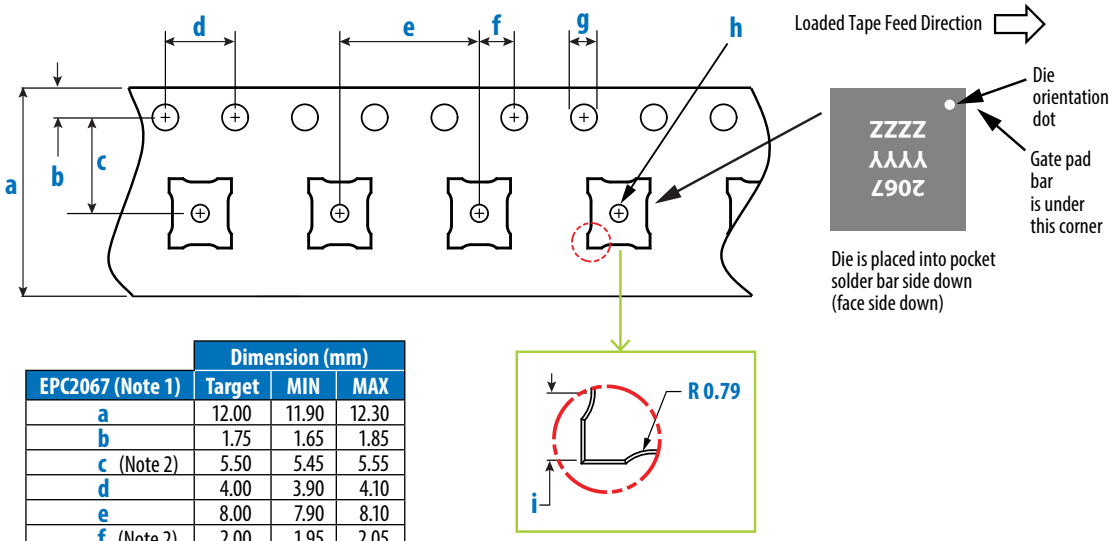
Figure 12: Safe Operating Area



TAPE AND REEL CONFIGURATION

8 mm pitch, 12 mm wide tape on 7" reel



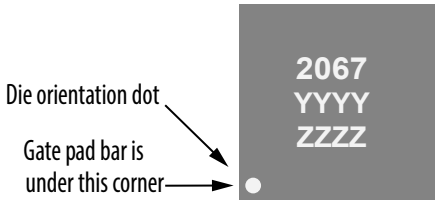


EPC2067 (Note 1)	Dimension (mm) Target	MIN	MAX
a	12.00	11.90	12.30
b	1.75	1.65	1.85
c (Note 2)	5.50	5.45	5.55
d	4.00	3.90	4.10
e	8.00	7.90	8.10
f (Note 2)	2.00	1.95	2.05
g	1.50	1.50	1.60
h	1.00	0.95	1.05
i	1.27		

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.

Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

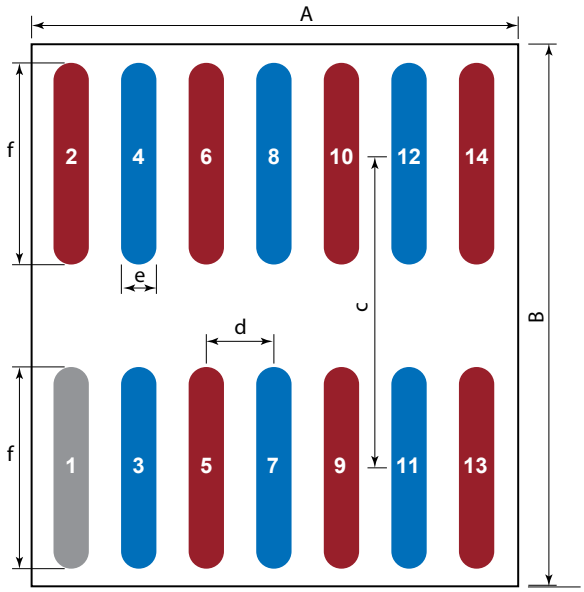
DIE MARKINGS



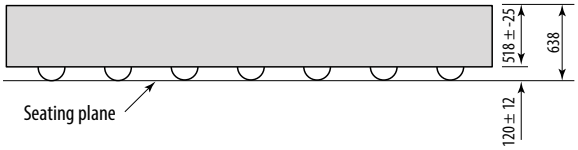
Part Number	Laser Markings Part # Marking Line 1	Lot_Date Code Marking Line 2	Lot_Date Code Marking Line 3
EPC2067	2067	YYYY	ZZZZ

DIE OUTLINE

Solder Bump View



Side View



DIM	Micrometers MIN	Nominal	MAX
A	2820	2850	2880
B	3220	3250	3280
c		1805	
d		400	
e		200	
f		1195	

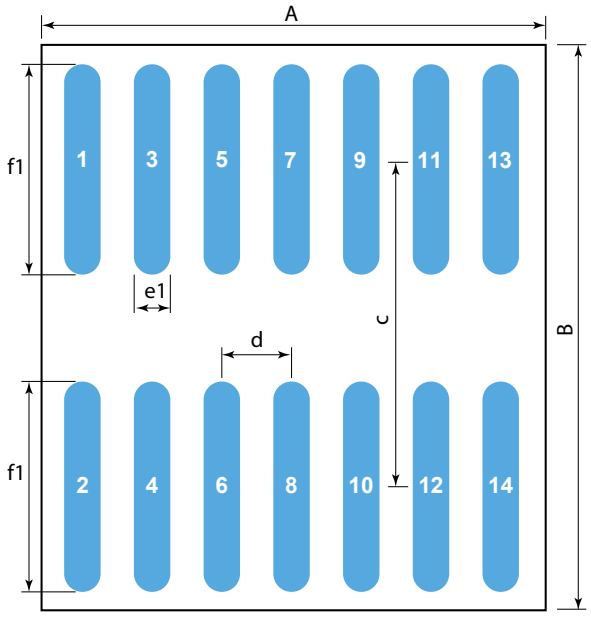
Pad 1 is Gate;

Pads 2,5,6,9,10,13,14 are Source;

Pads 3,4,7,8,11,12 are Drain

RECOMMENDED LAND PATTERN

(units in µm)



Land pattern is solder mask defined.

Pad 1 is Gate;

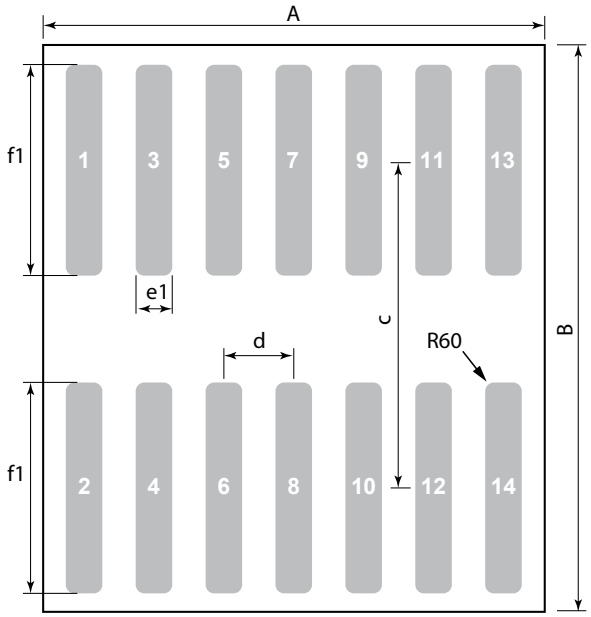
Pads 2,5,6,9,10,13, 14 are Source;

Pads 3,4,7,8,11,12, are Drain

DIM	Micrometers
A	2850
B	3250
c	1805
d	400
e1	180
f1	1175

RECOMMENDED STENCIL DRAWING

(units in µm)



DIM	Micrometers
A	2850
B	3250
c	1805
d	400
e1	180
f1	1175

Recommended stencil should be 4 mil (100 µm) thick, , laser cut stainless steel, opening per drawing.

The corner has a radius of R60.

Intended for use with SAC305 Type 4 solder, reference 88.5% metals content.

Additional assembly resources available at https://epc-co.com/epc/design-support